

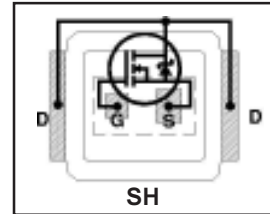
# International IR Rectifier

# IRF6655PbF IRF6655TRPbF DirectFET™ Power MOSFET ②

- RoHs Compliant ①
- Lead-Free (Qualified up to 260°C Reflow)
- Application Specific MOSFETs
- Ideal for High Performance Isolated Converter Primary Switch Socket
- Ideal for Control FET sockets in 36V-75V in Synchronous Buck applications
- Low Conduction Losses
- High Cdv/dt Immunity
- Low Profile (<0.7mm)
- Dual Sided Cooling Compatible ①
- Compatible with existing Surface Mount Techniques ①

Typical values (unless otherwise specified)

V <sub>DS</sub>		V <sub>GS</sub>		R <sub>DS(on)</sub>	
100V max		±20V max		53mΩ @ 10V	
Q <sub>g tot</sub>	Q <sub>gd</sub>	Q <sub>gs2</sub>	Q <sub>rr</sub>	Q <sub>oss</sub>	V <sub>gs(th)</sub>
8.7nC	2.8nC	0.58nC	37nC	4.5nC	4.0V



Applicable DirectFET Outline and Substrate Outline (see p.7,8 for details)①

SQ	SX	ST	<b>SH</b>	MQ	MX	MT	MN			
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## Description

The IRF6655PbF combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest combined on-state resistance and gate charge in a package that has a footprint similar to that of a micro-8, and only 0.7mm profile. The DirectFET package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infrared or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, improving previous best thermal resistance by 80%.

The IRF6655PbF is optimized for low power primary side bridge topologies in isolated DC-DC applications, and for high side control FET sockets in non-isolated synchronous buck DC-DC applications for use in wide range universal Telecom systems (36V – 75V), and for secondary side synchronous rectification in regulated DC-DC topologies. The reduced total losses in the device coupled with the high level of thermal performance enables high efficiency and low temperatures, which are key for system reliability improvements, and makes this device ideal for high performance isolated DC-DC converters.

## Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	100	V
V <sub>GS</sub>	Gate-to-Source Voltage	±20	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ③	4.2	A
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ③	3.4	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ④	19	
I <sub>DM</sub>	Pulsed Drain Current ⑤	34	
E <sub>AS</sub>	Single Pulse Avalanche Energy ⑥	11	mJ
I <sub>AR</sub>	Avalanche Current ⑤	5.0	A

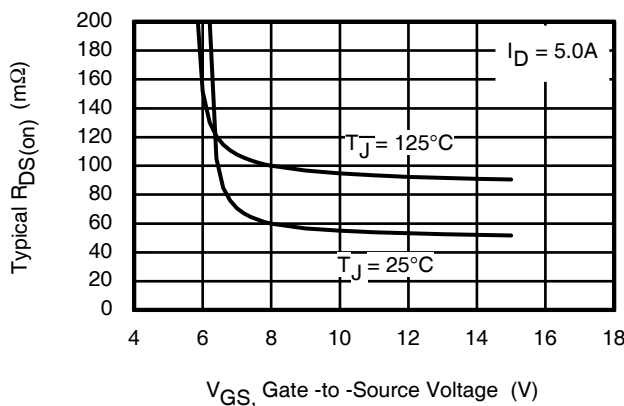


Fig 1. Typical On-Resistance vs. Gate Voltage

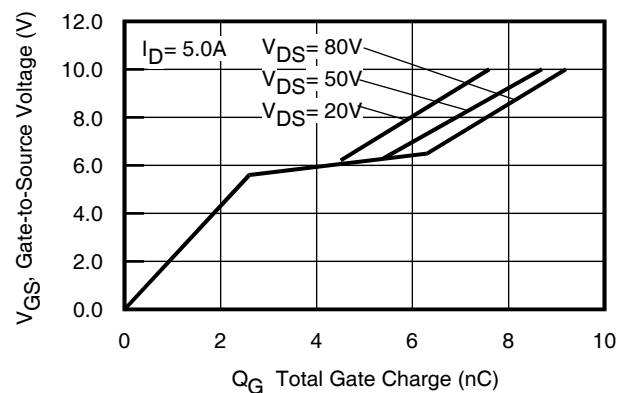


Fig 2. Typical On-Resistance Vs. Gate Voltage

Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.

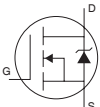
- ④ T<sub>C</sub> measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- ⑥ Starting T<sub>J</sub> = 25°C, L = 0.89mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 5.0A.

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## Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions	
$BV_{DSS}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$	
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.12	—	V/°C	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$	
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	53	62	mΩ	$V_{GS} = 10V, I_D = 5.0A$ ②	
$V_{GS(th)}$	Gate Threshold Voltage	2.8	4.0	4.8	V	$V_{DS} = V_{GS}, I_D = 25\mu A$	
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-11	—	mV/°C		
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	20	μA	$V_{DS} = 100V, V_{GS} = 0V$	
		—	—	250		$V_{DS} = 80V, V_{GS} = 0V, T_J = 125^\circ\text{C}$	
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$	
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$	
$g_{fs}$	Forward Transconductance	6.6	—	—	S	$V_{DS} = 10V, I_D = 5.0A$	
$Q_g$	Total Gate Charge	—	8.7	11.7	nC	$V_{DS} = 50V$ $V_{GS} = 10V$ $I_D = 5.0A$ See Fig. 15	
$Q_{gs1}$	Pre-Vth Gate-to-Source Charge	—	2.1	—			
$Q_{gs2}$	Post-Vth Gate-to-Source Charge	—	0.58	—			
$Q_{gd}$	Gate-to-Drain Charge	—	2.8	4.2			
$Q_{godr}$	Gate Charge Overdrive	—	3.2	—			
$Q_{sw}$	Switch Charge ( $Q_{gs2} + Q_{gd}$ )	—	3.4	—			
$Q_{oss}$	Output Charge	—	4.5	—	nC	$V_{DS} = 16V, V_{GS} = 0V$	
$R_G$	Gate Resistance	—	1.9	2.9	Ω		
$t_{d(on)}$	Turn-On Delay Time	—	7.4	—	ns	$V_{DD} = 50V, V_{GS} = 10V$ ② $I_D = 5.0A$ $R_G = 6.0\Omega$ See Fig. 16 & 17	
$t_r$	Rise Time	—	2.8	—			
$t_{d(off)}$	Turn-Off Delay Time	—	14	—			
$t_f$	Fall Time	—	4.3	—			
$C_{iss}$	Input Capacitance	—	530	—	pF	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1.0\text{MHz}$	
$C_{oss}$	Output Capacitance	—	110	—			
$C_{riss}$	Reverse Transfer Capacitance	—	29	—			
$C_{oss}$	Output Capacitance	—	510	—			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	67	—			$V_{GS} = 0V, V_{DS} = 80V, f = 1.0\text{MHz}$

## Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	38	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ⑤	—	—	34		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 5.0A, V_{GS} = 0V$ ⑦
$t_{rr}$	Reverse Recovery Time	—	31	47	ns	$T_J = 25^\circ\text{C}, I_F = 5.0A, V_{DD} = 25V$
$Q_{rr}$	Reverse Recovery Charge	—	37	56	nC	$di/dt = 100A/\mu s$ ⑦ See Fig. 18

### Notes:

⑤ Repetitive rating; pulse width limited by max. junction temperature.

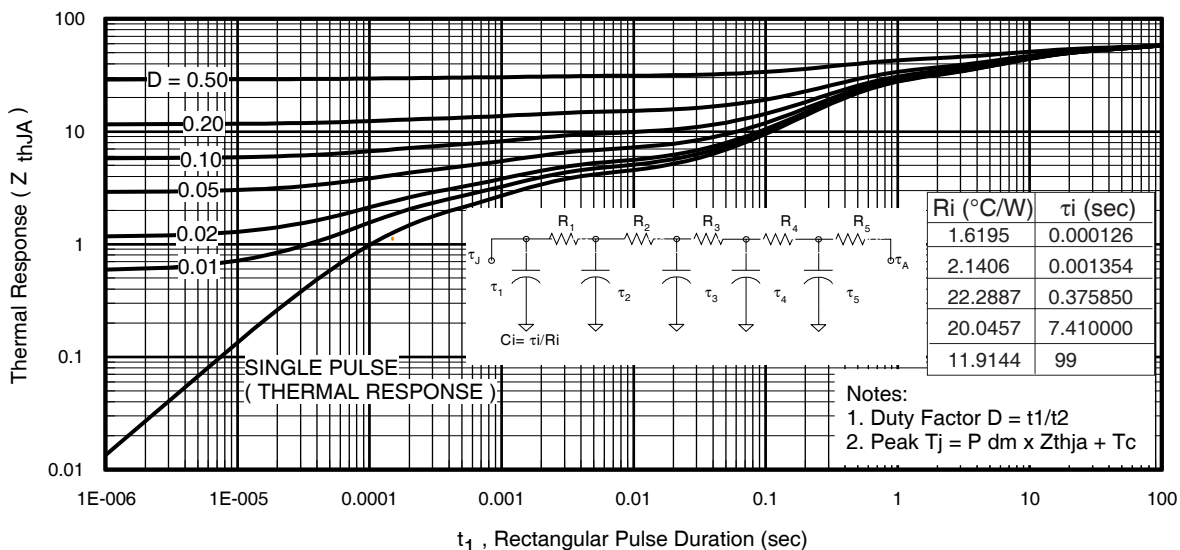
⑦ Pulse width  $\leq 400\mu s$ ; duty cycle  $\leq 2\%$ .

**Absolute Maximum Ratings**

	Parameter	Max.	Units
$P_D @ T_A = 25^\circ\text{C}$	Power Dissipation ③	2.2	W
$P_D @ T_A = 70^\circ\text{C}$	Power Dissipation ③	1.4	
$P_D @ T_C = 25^\circ\text{C}$	Power Dissipation ④	42	
$T_P$	Peak Soldering Temperature	270	°C
$T_J$	Operating Junction and	-40 to + 150	
$T_{STG}$	Storage Temperature Range		

**Thermal Resistance**

	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③ ①	—	58	°C/W
$R_{\theta JA}$	Junction-to-Ambient ⑨ ①	12.5	—	
$R_{\theta JA}$	Junction-to-Ambient ⑩ ①	20	—	
$R_{\theta JC}$	Junction-to-Case ④ ①	—	3.0	
$R_{\theta J-PCB}$	Junction-to-PCB Mounted	1.4	—	
	Linear Derating Factor ③	0.017		W/°C



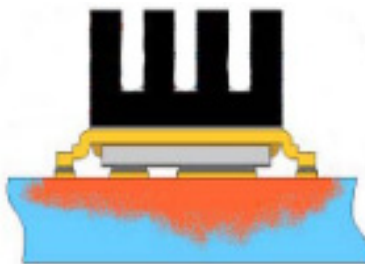
**Fig 3. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient**

**Notes:**

- ③ Used double sided cooling, mounting pad.
- ④ Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- ①  $R_{\theta}$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .



③ Surface mounted on 1 in. square Cu (still air).



⑨ Mounted to a PCB with small clip heatsink (still air)



⑩ Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

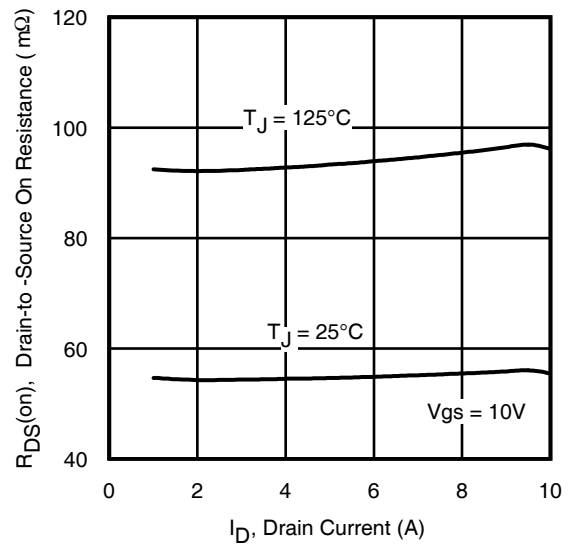
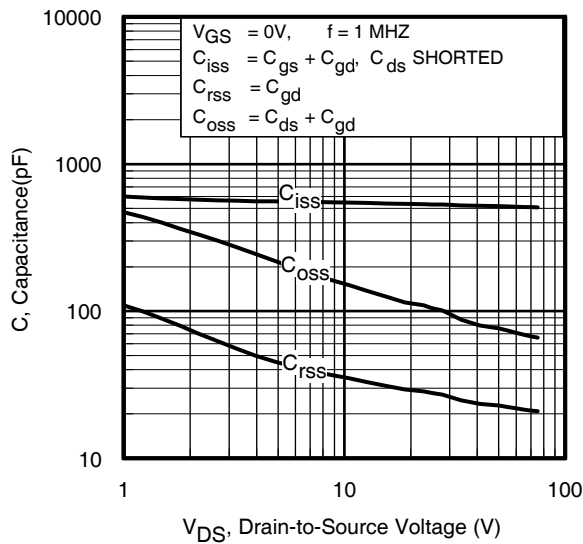
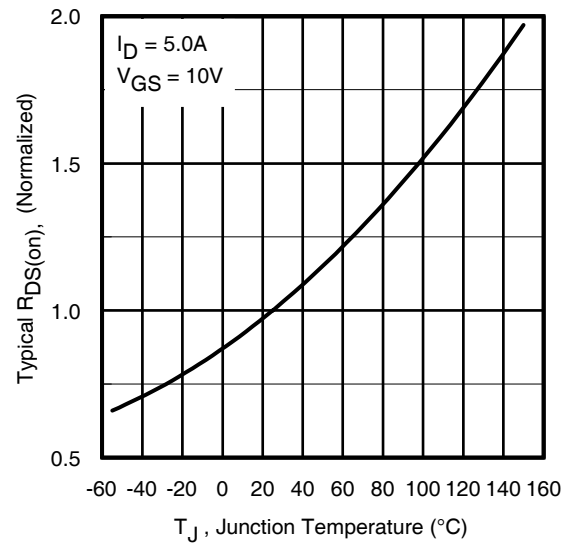
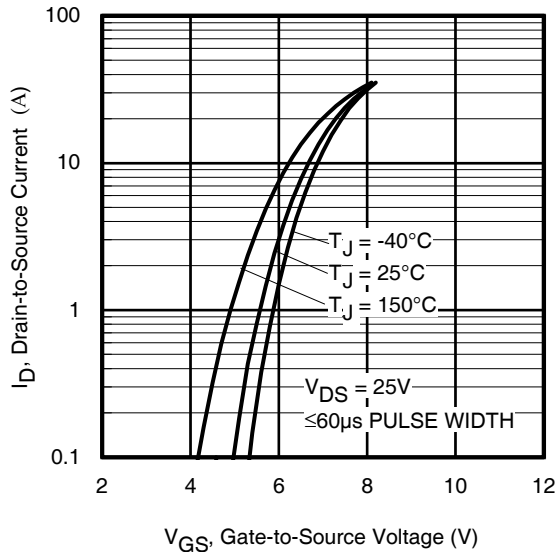
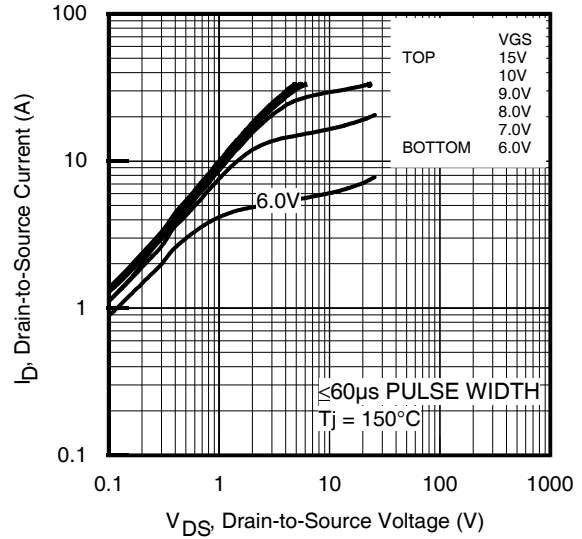
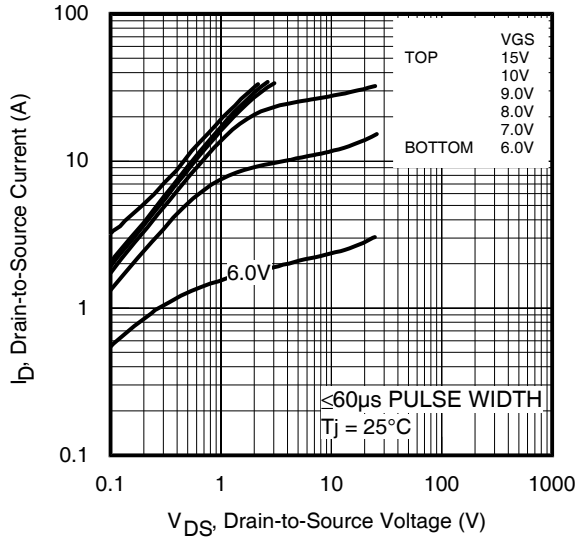


Fig 8. Typical Capacitance vs. Drain-to-Source Voltage  
4

Fig 9. Normalized Typical On-Resistance vs. Drain Current and Gate Voltage  
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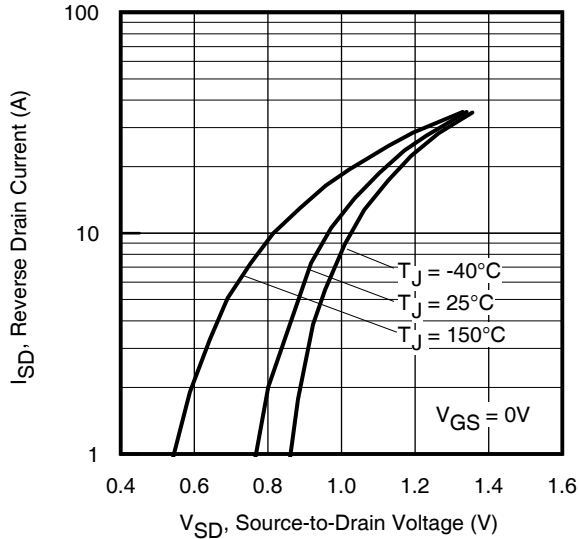


Fig 10. Typical Source-Drain Diode Forward Voltage

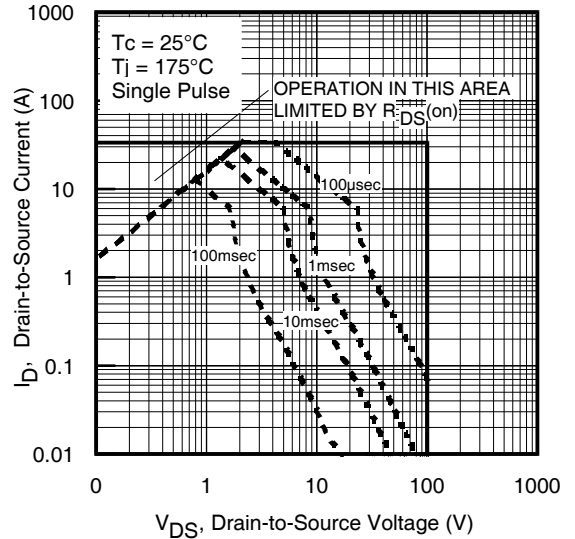


Fig11. Maximum Safe Operating Area

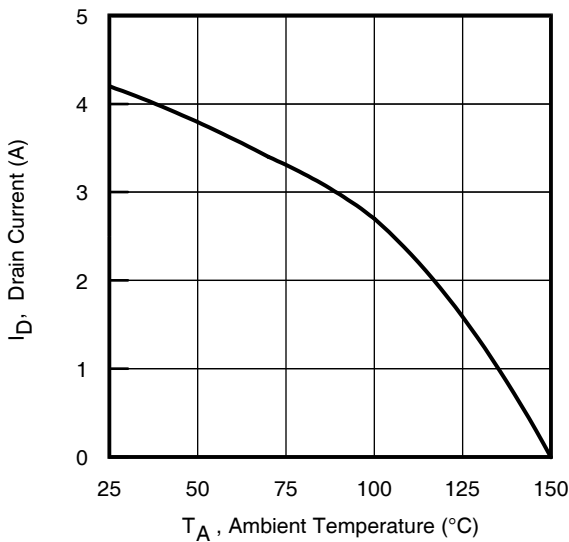


Fig 12. Maximum Drain Current vs. Ambient Temperature

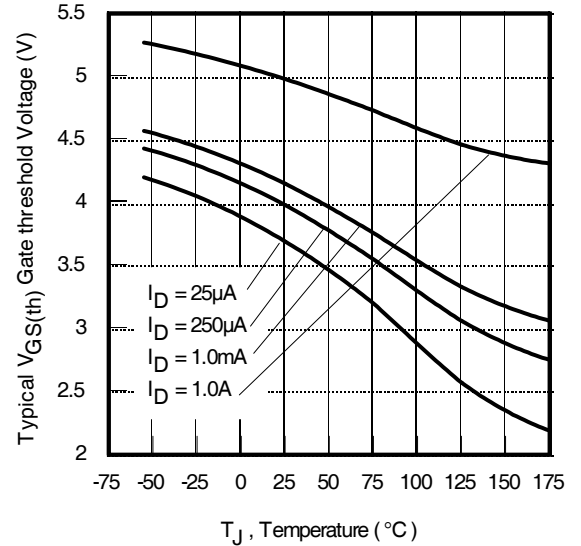


Fig 13. Threshold Voltage vs. Temperature

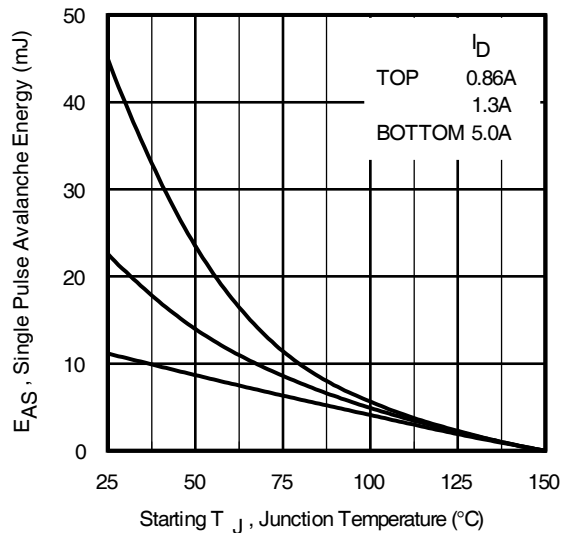
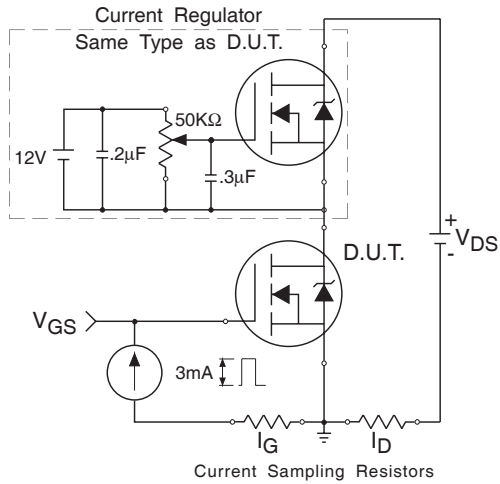
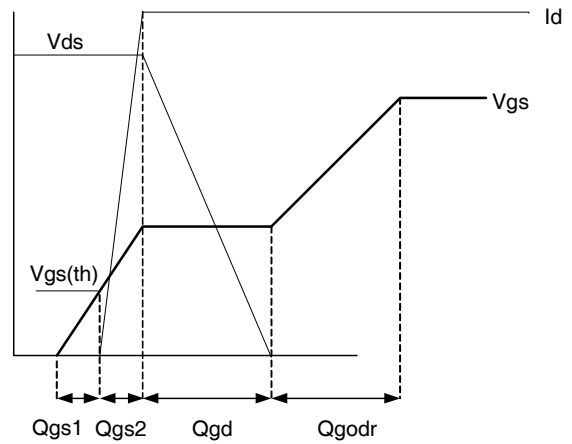


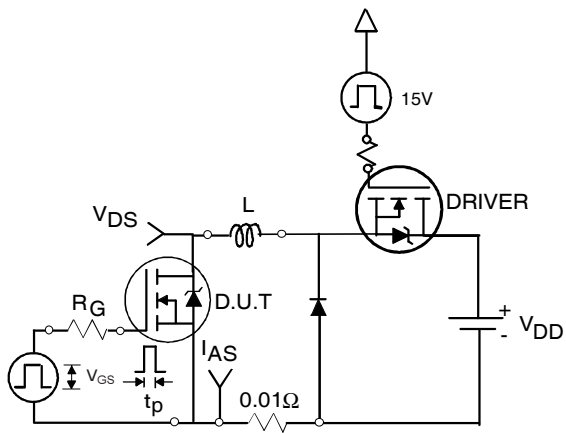
Fig 14. Maximum Avalanche Energy vs. Drain Current



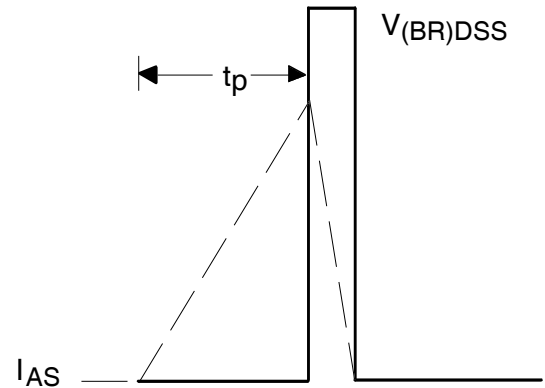
**Fig 15a.** Gate Charge Test Circuit



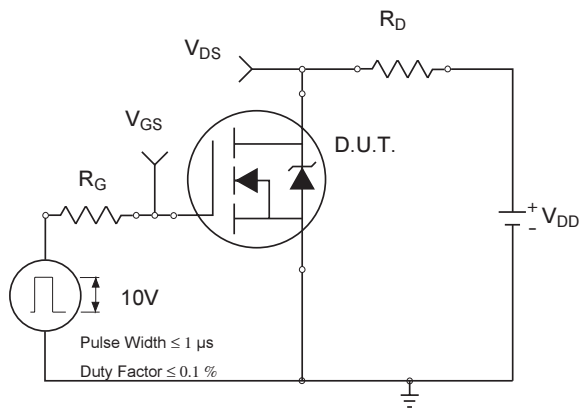
**Fig 15b.** Gate Charge Waveform



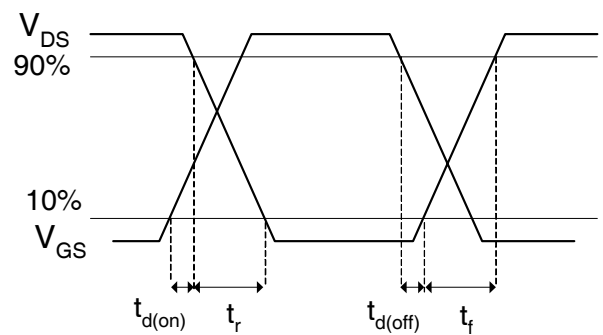
**Fig 16a.** Unclamped Inductive Test Circuit



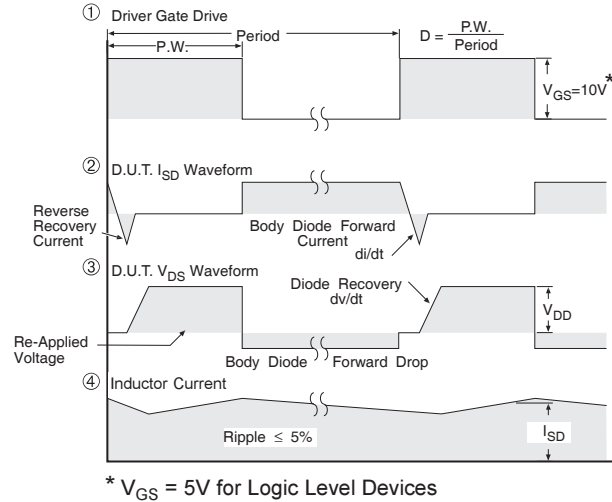
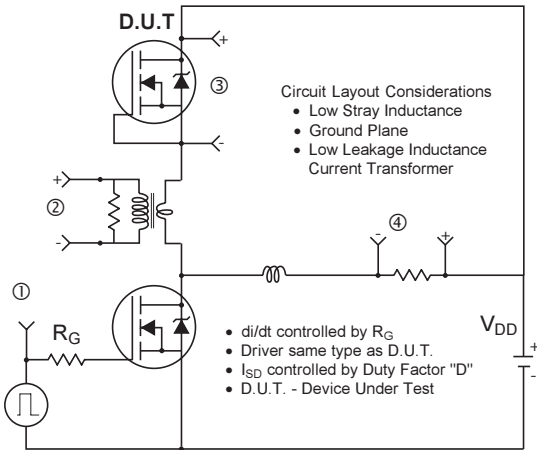
**Fig 16b.** Unclamped Inductive Waveforms



**Fig 17a.** Switching Time Test Circuit



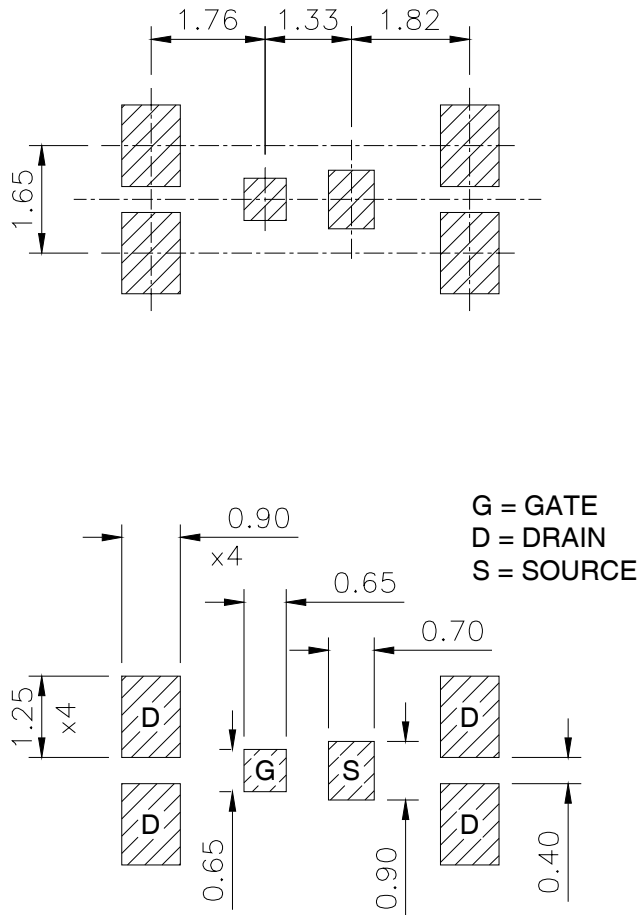
**Fig 17b.** Switching Time Waveforms



**Fig 18.** Diode Reverse Recovery Test Circuit for N-Channel HEXFET® Power MOSFETs

**DirectFET™ Substrate and PCB Layout, SH Outline ③**  
(Small Size Can, H-Designation).

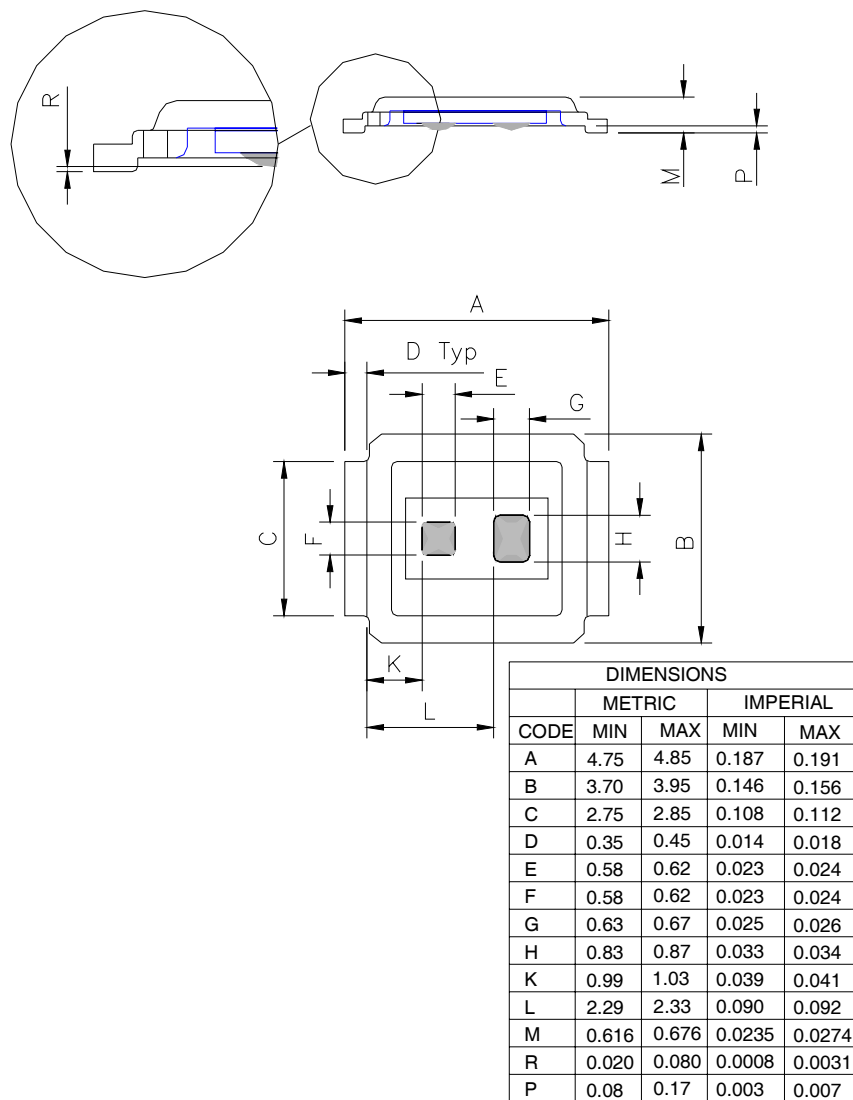
Please see DirectFET application note AN-1035 for all details regarding PCB assembly using DirectFET. This includes all recommendations for stencil and substrate designs.



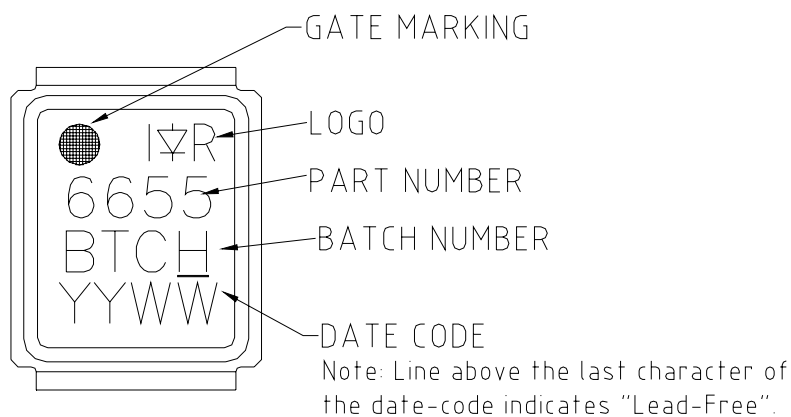
# IRF6655PbF

## DirectFET™ Outline Dimension, SH Outline (Small Size Can, H-Designation).

Please see DirectFET application note AN-1035 for all details regarding PCB assembly using DirectFET. This includes all recommendations for stencil and substrate designs.

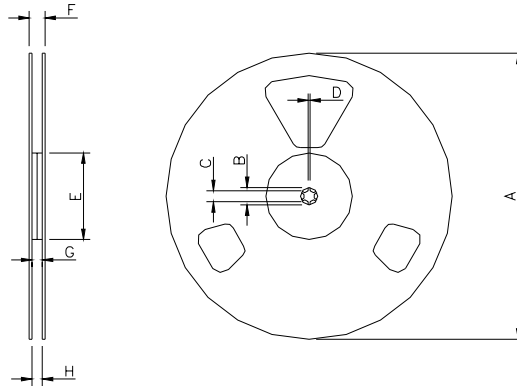


## DirectFET™ Part Marking





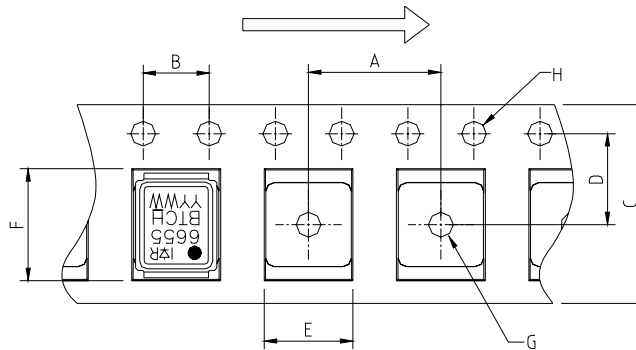
## DirectFET™ Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm  
 Std reel quantity is 4800 parts. (ordered as IRF6655TRPBF). For 1000 parts on 7" reel, order IRF6655TR1PBF

REEL DIMENSIONS								
CODE	STANDARD OPTION (QTY 4800)				TR1 OPTION (QTY 1000)			
	METRIC		IMPERIAL		METRIC		IMPERIAL	
	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX
A	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C
B	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C
C	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C
E	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C
H	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C

Loaded Tape Feed Direction



CODE	DIMENSIONS			
	METRIC		IMPERIAL	
	MIN	MAX	MIN	MAX
A	7.90	8.10	0.311	0.319
B	3.90	4.10	0.154	0.161
C	11.90	12.30	0.469	0.484
D	5.45	5.55	0.215	0.219
E	4.00	4.20	0.158	0.165
F	5.00	5.20	0.197	0.205
G	1.50	N.C	0.059	N.C
H	1.50	1.60	0.059	0.063

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Consumer market.  
 Qualification Standards can be found on IR's Web site.

Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>

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